Chemical Structure*) ZRf2Rf6N(CF2)n Rf8 is -CF3, -CmF2m+1, or -(CF2)q-SO2-X-M+; Rf6 and Rf7, independently, are perfluoroalkylene moieties having the formula -CrF2r; n is 1-4; r is 1-4;m is 1-12; q is 1-4; and M+ is a counterion.

5514518

METHOD OF IMPROVING DELAMINATION IN AN IMAGE FORMING MATERIAL UTILIZING 2-DIAZO-1,2-QUINONE COMPOUNDS HAVING FLUORINE CONTAINING SUBSTITUENT GROUPS

Wakamatsu Kan; Wakata Yuichi; Satomura Masato; Namiki Tomizo Shizuoka, JAPAN assigned to Fuji Photo Film Co Ltd

A 2-diazo-1,2-quinone compound having a substituent group containing an alkyl group which is substituted by at least one fluorine atom is described. This compound has a capacity to change its polarity when exposed to light. The invention also provides an image forming material in which the invention compound is added to at least one of laminated layers. When these laminated layers are exposed to light, the adhesiveness of the compound-containing layer to its adjoining layer is reduced effectively due to the polarity-changing ability of the compound, thus making the easy delamination of the layers possible. This compound is applicable to many instances in which image receiving sheets are used, such as the formation of a multi-color image by a transfer method (a color proof, for example) and the preparation of a printing plate of the delamination development type.

5514526

FLUORINE-CONTAINING COMPOSITION FOR FORMING ANTI-REFLECTION FILM ON RESIST SURFACE AND PATTERN FORMATION METHOD

Nishi Mineo; Makishima Hideo Kitakyushu, JAPAN assigned to Mitsubishi Chemical Corporation

PCT No. PCT/JP93/00711 Sec. 371 Date Feb. 2, 1994

Sec. 102(e) Date Feb. 2, 1994 PCT Filed May 27, 1993 PCT Pub. No. WO93/24860 PCT Pub. Date Dec. 9, 1993. A composition for forming anti-reflection film on resist surface which comprises an aqueous solution of a water soluble fluorine compound, and a pattern formation method which comprises the steps of coating a photoresist composition on a substrate; coating the composition forming above-mentioned for anti-reflection film; exposing the coated film to form a specific pattern; and developing the photoresist, are provided. Since the composition for forming anti-reflection film can be coated on the photoresist in the form of an aqueous solution, not only the anti-reflection film can be formed easily, but also, the film can be removed easily by rinsing with water or alkali development. Therefore, by the pattern formation method according to the present invention, it is possible to form a pattern easily with a high dimensional accuracy.

5514720

STABLE EMULSIONS OF HIGHLY FLUORINATED ORGANIC COMPOUNDS

Clark Leland C; Shaw Robert Cincinnati, OH, UNITED STATES assigned to HemaGen/PFC

Stable emulsions of highly fluorinated organic compounds for use as oxygen transport agents, artificial bloods or red blood cell substitutes and as contrast agents for biological imaging. The emulsions comprise a highly fluorinated organic compound, an oil that is not substantially surface active and not significantly soluble in water, a surfactant and water.

5514724

DIMENSIONALLY STABLE CLOSED CELL RIGID POLYISOCYANATE BASED FOAM PREPARED FROM A FROTH FOAMING MIXTURE

Green Todd J; Tucker John R Canton, MI, UNITED STATES assigned to BASF Corporation